


<b>Search Notes</b>  	<b>Application/Control No.</b>  10531809	<b>Applicant(s)/Patent Under Reexamination</b>  GRANIER ET AL.
	<b>Examiner</b>  THUY-AI N NGUYEN	<b>Art Unit</b>  1796

SEARCHED			
Class	Subclass	Date	Examiner
512	1	02/29/2008	THA

SEARCH NOTES		
Search Notes	Date	Examiner
Performed the inventor search in East and Palm	02/13/2008	THA
Searched in East for US-PGPUB, USPAT; EPO; JPO; DERWENT	02/13/2008	THA
Have STIC search	02/26/2008	THA
updated EAST search (USPGPUB, USPAT, EPO, JPO, DERWENT) see attached sheet	9/11/2008	PFG
STN structure search (see attached sheet)	9/10/2008	PFG
updated search	03/06/2009	THA

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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